

Search Notes

Application/Control No.

10/046,304

Examiner

Raj K. Jain

Applicant(s)/Patent under
Reexamination

MORIWAKI ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search (scheduled\$4 switch capacity0	3/23/2004	RJ
USPGPUB, USPAT	3/23/2004	RJ
370/230,386,390,398,395.2,395.4 (text search, see printout)	3/23/2004	RJ
370/412,413,422,423,400,428 (text search, see printout)	3/23/2004	RJ